

Detection of defects in displacement-damaged tungsten and iron

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Jožef Stefan





EUROfusion Enabling research project - DeHydroC - ENR-MAT-01-JSI





- Methodology
- Detection of defects by Rutherford Backscattering Spectroscopy in Channeling configuration (RBS-C) in W
- RBSADEC modelling
- Detection of defects by Rutherford Backscattering Spectroscopy in Channeling configuration (RBS-C) in Fe
- Conclusion

Motivation



Hydrogen isotope interaction with displacement damage material

Tungsten and steels – first wall and divertor



Separating individual aspects of the interaction





Damaged layer characterization by Scanning Transmission Electron Microscopy (STEM) [Založnik et al. Phys Scr. T167 (2016) 014031]

e.g.: S. Markelj JNM 469 (2016) 133–144; Založnik et al. Phys Scr. T167 (2016) 014031; S. Markelj et al., Nucl. Fusion 59 (2019) 086050; M. Pečovnik et al., Nucl. Fusion 60 (2020) 036024; etc. W ion irradiation by MeV W ions

- Creation of displacement damage
- Dense cascades
- Exposure to D atoms/ions to only populate the existing traps without producing new ones
- Open volume defects are traps for hydrogen isotopes [S. M. Myers et al., JNM 165 (1989) 9–64]

Methodology to quantify D retention, defect evolution and defect concentration:

- Measure D concentration by nuclear reaction analysis (NRA) via D(³He,p)⁴He
- Desorption kinetics by thermal desorption spectroscopy (TDS)
- Use macroscopic rate equation modelling

Which defects are really responsible for hydrogen isotope retention? Where does hydrogen sit? Can we get more information about the defects?

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Amorphous material

Random direction

Pristine crystal - aligned

• Defect type? Sensitive mainly to dislocation structure (loops, lines)

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Dis-ordered crystal - aligned





- Disorder in materials due to irradiation (depth resolved)
 Defect type?
- Sensitive mainly to dislocation structure (loops, lines)

- Deuterium populates defects in materials – analysis depth resolved
 Defect type?
- D traps mainly in open volume defects (vacancies, vacancy clusters)



Heinola et al. PR B (2010)

Hydrogen atom positions around

vacancy/vacancy cluster



- Disorder in materials due to irradiation (depth resolved)
 Defect type?
- Sensitive mainly to dislocation structure (loops, lines)

- Deuterium populates defects in materials – analysis depth resolved
 Defect type?
- D traps mainly in open volume defects (vacancies, vacancy clusters)





Creation of defects in tungsten – different dominating defect



Samples: tungsten single crystals (111) and (100) RBS-C NRA-C

Irradiation: 10.8 MeV W ions

@ two damage doses and two temperatures to create different dominating open volume defect types





'gentle' loading = 'decoration' of defects ion flux: $6 \times 10^{19} \text{ D/(m}^2\text{s})$ ion fluence: $1 \cdot 10^{25} \text{ D/m}^2$ (48 h)

 ✓ Initial assumptions on open volume defects based on Hu et al. JNM 556 (2022) 153175
 ✓ Confirmed by Positron Annihilation

Spectroscopy (PAS)



W (100)

Sample	Irradiation conditions	Predominant defect expected	Vacancy cluster size by PAS
78g / #1	0.02 dpa, 290 K	single vacancies	v = 2
78f / #5	0.2 dpa, 290K	heavily damaged standard	v = 2 - 4
78c / #3	0.02 dpa, 800 K	small vacancy clusters	v = 25
78b / #2	0.2 dpa, 800 K	big vacancy clusters	v = 50

See: J. Zavašnik et al. Materials Characterization 224 (2025) 115050.

Transmission electron microscopy (TEM) analysis – dislocations, voids



Low dose 0.02 dpa

High dose 0.2 dpa



See: J. Zavašnik et al. Materials Characterization 224 (2025) 115050.

D retention in W damaged samples





Temperature [K]

C-RBS – measurements



- Backscattered ⁴He ions along <111> channel
- Spectrum from pristine W @ 4.5 MeV
- Random = Σ100 spectra nonchanneling
- Ratio of the signal between Pristine/Random after the surface peak = 1.3 %
- Starting material (pristine sample) has a very good crystallinity



Measurements were preformed at CMAM, Madrid



[S. Markelj, et al., Acta Mater., 263 (2024) 119499]

C-RBS - measurements



- Backscattered ⁴He ions along <111> channel
- RBS-C spectra @ 4.5 MeV Irradiation at 290 K:
- 78f : 0.2dpa, 290 K (heavily damaged standard)
- 78g: 0.02 dpa, 290 K (single vacancies)



[S. Markelj, et al., Acta Mater., 263 (2024) 119499]

Measurements were preformed at CMAM, Madrid



C-RBS - measurements





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3000

Energy (keV)

3500

4500

4000

4.5 MeV

Random

2500

Depth (um)

1.0

0.5

0.0

1.5

Measurements were preformed at CMAM, Madrid

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Multi-energy RBS-C along <111> channel









Following: FELDMAN, MATERIALS ANALYSIS BY ION CHANNELING. Submicron Crystallography, 1982, Academic press

78f (0.2 dpa, 290 K): positive slope –extended defects – dislocation lines (TEM)

78g (0.02 dpa, 290 K): no slope – localized defects – small dislocation loops (TEM)

78b (0.2 dpa, 800 K): no slope – localized defects – dislocation lines and black dots (TEM)

78c (0.02 dpa, 800 K): no slope – localized defects – dots and isolated lines (TEM)

• Good qualitative agreement with TEM

[J. Zavašnik et al. Materials Char. 224 (2025) 115050.] Markelj, MoD PMI, 26 – 28. May 2025 | Page 17

Simulation of RBS-C spectra using MD – samples irradiated at R.T.



A. Get depth distribution of damage level (SRIM)



B. MD simulations and assemble of MD cells



Creation of radiation defects by Molecular Dynamics (MD) calculation

MD cells with certain number of collision cascades Primary knock-on atom: 10 keV **Size of MD cells: ~ 20nm** Overlapping of cascades: High damage dose (evolution of defects) *[F. Granberg et al., J. Nucl. Mater. 556 (2021) 153158]*

Incorporation of merged MD cells into RBSADEC

simulation code

C. Simulation and comparison of RBS-C spectra



Multi-energy RBS-C (0.02 dpa, 290 K) – MD input





[S. Markelj, et al., Acta Mater. 263 (2024) 119499]

Multi-energy RBS-C (0.2 dpa, 290 K) – MD



(S. Markelj, et al., Acta Mater., 263 (2024) 119499)



RBS-C experiments (high damage, 0.2 dpa)

- Higher yield than that of 0.02 dpa
- RBS-C simulations (MD cells)
- Dechannelling as <u>a function</u> of E



Lacking agreement between experiment and simulation due to limited size of MD cells.



- Dense networks of dislocation lines (length > 100 nm).
- No lines in MD cells: limited size of cells



Multi-energy RBS-C (0.2 dpa, 290 K) – effect of MD potentials





[D. Mason, et al., J. Phys. Condens. Matter, 35, 2023]

Multi-energy RBS-C (290 K vesus 800 K, 0.02 dpa)



The BCA-MD approach (dots)





Agreements are not optimal at 800 K:

 With a higher temperature, the experimental yield is smaller. But in simulations using the BCA-MD approach, the yields are almost the same.
 Dislocation densities in MD cells only decrease a bit.

- No agreement with experiment
- MD no time/temperature evolution of the defects

Simulation of RBS-C spectra at 800 K



R.T. and 800 K from fitting



 From R.T. to 800 K, the decrease of RBS-C yield is due to a significant decrease of dislocation density. (This is not reproduced in BCA-MD approach)



TEM analysis indeed shows the same trend of loop distribution









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Displacement damage in Fe single crystal



- >On the experimental evidence of C15 cluster in Fe
- Small SIA clusters are most stable in the form of agglomerates of C15 (1/2 <111> loops for W)
- DFT predicts C15 clusters to be energetically favoured over dislocation loops at small cluster sizes, low doses.





J. Byggmastar and F. Granberg, JNM 528 (2020) 151893

Displacement damage in Fe single crystal - C15



 On the experimental evidence of C15 cluster in Fe – dominant defect at low damage doses



- Irradiate Fe (100) single crystals by Fe ions
 @ 290 K
- 0.02 dpa C15 dominating
- 0.2 dpa ½<111> loops dominating

RBS-C on displacement damaged Fe (100)

On the experimental evidence of C15 cluster in Fe – dominant defect at low damage doses



- No disorder detected
- INTERSTITIAL AND VACANCIES mobile at 290 K no the case for W – if no impurities (C) are present to stabilize the defects
- MD / DFT calculations at 300 K / 0 K no defect time evolution
- Next step irradiation and RBS-C at LN temperatures S. Markelj

Conclusions



- **RBS-C** can provide us a unique way for analyzing the depth distribution of defects.
- Multi-energy RBS-C is a good tool to study interstitial type of defects in the material (in situ)
 - Combined with RBS-C simulations on W targets, containing realistic defect structures, obtained from molecular dynamics simulations, gives deeper insight into defect structure
- RBS-C is the method to be used to validate the creation of dislocations by state of the art modelling (test potentials and test if the size of MD cell is adequate)!!
- Only experiment with modelling hand in hand can bring progress in the field

Measurements at JSI with new 6 axis manipulator



-0.5

